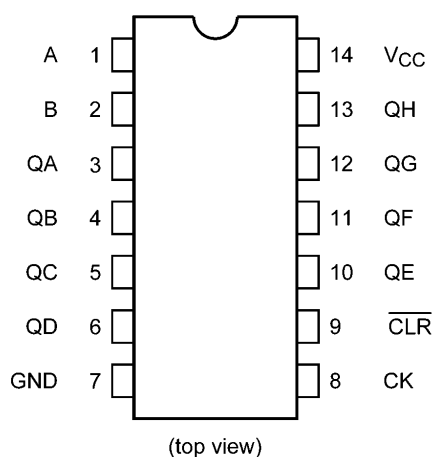
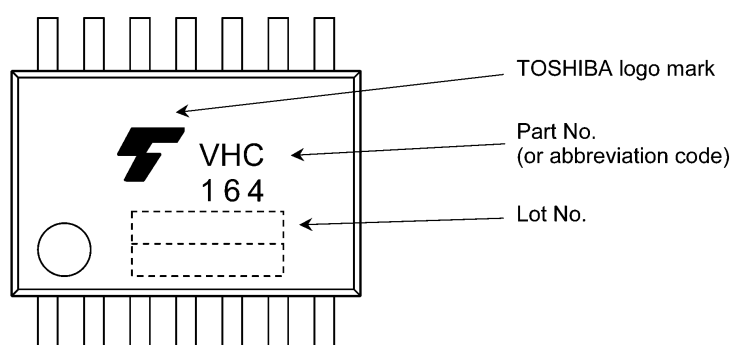


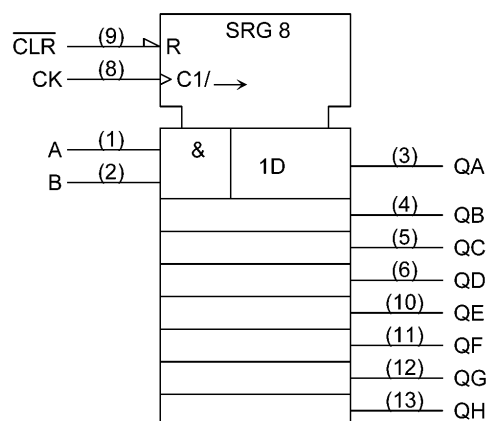
## 5. Pin Assignment







## 6. Marking



## 7. IEC Logic Symbol



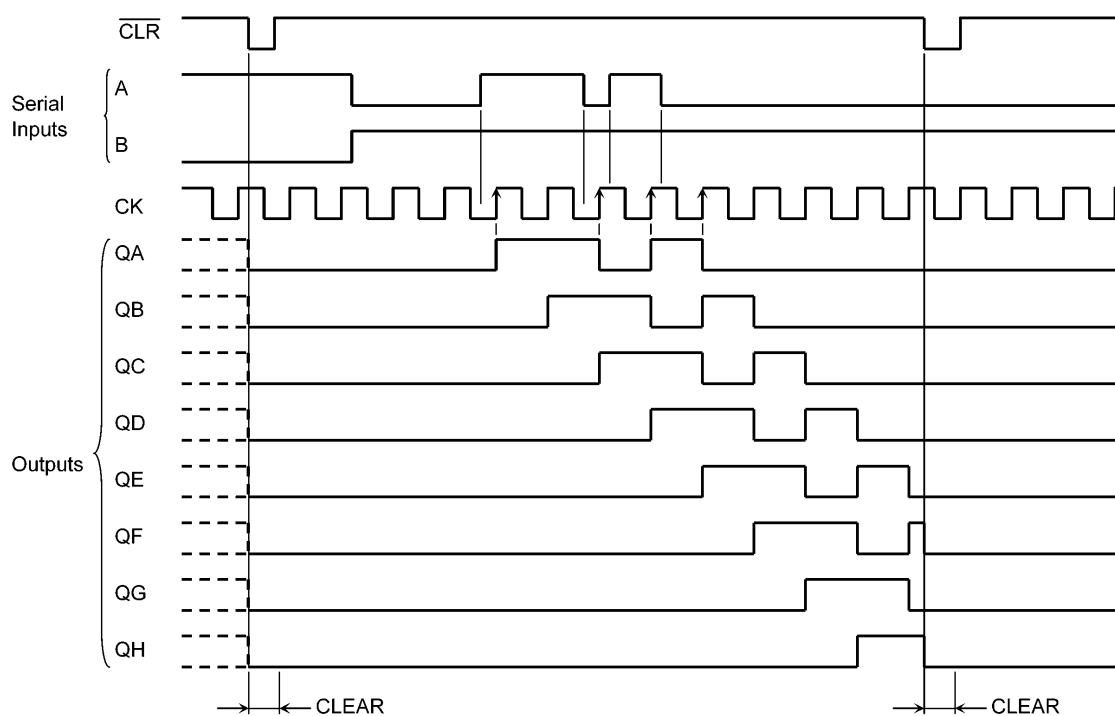
## 8. Truth Table

Inputs				Outputs			
$\overline{\text{CLR}}$	CK	Serial IN		QA	QB	...	QH
		A	B				
L	X	X	X	L	L	...	L
H		X	X	No Change			
H		L	X	L	QAn	...	QGn
H		X	L	L	QAn	...	QGn
H		H	H	H	QAn	...	QGn

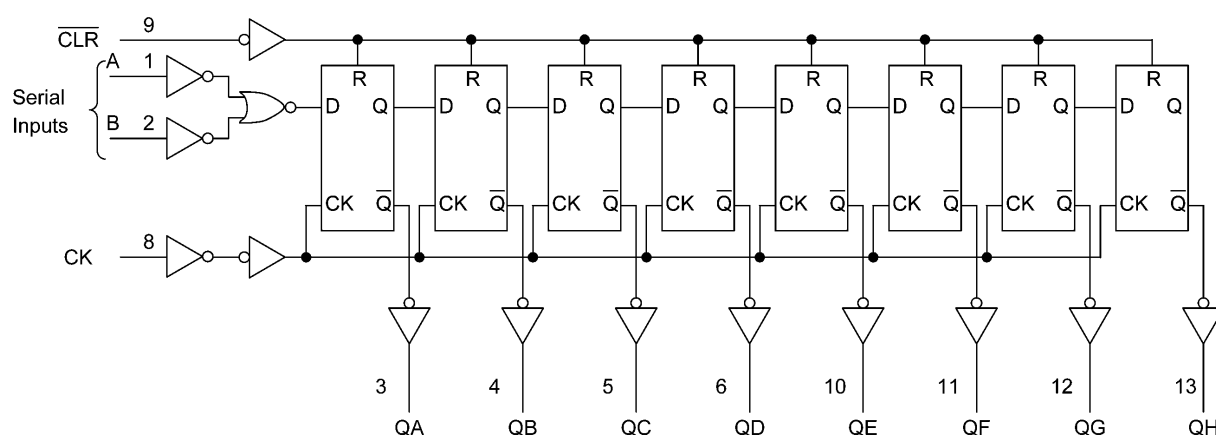
X: Don't care

QAn to QGn: The level of QA to QG, respectively, before the most recent positive edge of the CK.

## 9. Timing Diagrams



## 10. System Diagram



## 11. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	$V_{CC}$		-0.5 to 7.0	V
Input voltage	$V_{IN}$		-0.5 to 7.0	V
Output voltage	$V_{OUT}$		-0.5 to $V_{CC} + 0.5$	V
Input diode current	$I_{IK}$		-20	mA
Output diode current	$I_{OK}$		$\pm 20$	mA
Output current	$I_{OUT}$		$\pm 25$	mA
$V_{CC}$ /ground current	$I_{CC}$		$\pm 75$	mA
Power dissipation	$P_D$	(Note 1)	180	mW
Storage temperature	$T_{stg}$		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: 180 mW in the range of  $T_a = -40$  to  $85$  °C. From  $T_a = 85$  to  $125$  °C a derating factor of  $-3.25$  mW/°C shall be applied until 50 mW.

## 12. Operating Ranges (Note)

Characteristics	Symbol	Test Condition	Rating	Unit
Supply voltage	$V_{CC}$		2.0 to 5.5	V
Input voltage	$V_{IN}$		0 to 5.5	V
Output voltage	$V_{OUT}$		0 to $V_{CC}$	V
Operating temperature	$T_{opr}$		-40 to 125	°C
Input rise and fall times	$dt/dv$	$V_{CC} = 3.3 \pm 0.3$ V	0 to 100	ns/V
		$V_{CC} = 5 \pm 0.5$ V	0 to 20	

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either  $V_{CC}$  or GND.

### 13. Electrical Characteristics

#### 13.1. DC Characteristics (Unless otherwise specified, $T_a = 25\text{ }^{\circ}\text{C}$ )

Characteristics	Symbol	Test Condition		$V_{CC}$ (V)	Min	Typ.	Max	Unit
High-level input voltage	$V_{IH}$	—		2.0	1.50	—	—	V
				3.0 to 5.5	$V_{CC} \times 0.7$	—	—	
Low-level input voltage	$V_{IL}$	—		2.0	—	—	0.50	V
				3.0 to 5.5	—	—	$V_{CC} \times 0.3$	
High-level output voltage	$V_{OH}$	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -50\text{ }\mu\text{A}$	2.0	1.9	2.0	—	V
				3.0	2.9	3.0	—	
				4.5	4.4	4.5	—	
			$I_{OH} = -4\text{ mA}$	3.0	2.58	—	—	
			$I_{OH} = -8\text{ mA}$	4.5	3.94	—	—	
Low-level output voltage	$V_{OL}$	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OL} = 50\text{ }\mu\text{A}$	2.0	—	0.0	0.1	V
				3.0	—	0.0	0.1	
				4.5	—	0.0	0.1	
			$I_{OL} = 4\text{ mA}$	3.0	—	—	0.36	
			$I_{OL} = 8\text{ mA}$	4.5	—	—	0.36	
Input leakage current	$I_{IN}$	$V_{IN} = 5.5\text{ V or GND}$		0 to 5.5	—	—	$\pm 0.1$	$\mu\text{A}$
Quiescent supply current	$I_{CC}$	$V_{IN} = V_{CC} \text{ or GND}$		5.5	—	—	4.0	$\mu\text{A}$

#### 13.2. DC Characteristics (Unless otherwise specified, $T_a = -40 \text{ to } 85\text{ }^{\circ}\text{C}$ )

Characteristics	Symbol	Test Condition		$V_{CC}$ (V)	Min	Max	Unit
High-level input voltage	$V_{IH}$	—		2.0	1.50	—	V
				3.0 to 5.5	$V_{CC} \times 0.7$	—	
Low-level input voltage	$V_{IL}$	—		2.0	—	0.50	V
				3.0 to 5.5	—	$V_{CC} \times 0.3$	
High-level output voltage	$V_{OH}$	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -50\text{ }\mu\text{A}$	2.0	1.9	—	V
				3.0	2.9	—	
				4.5	4.4	—	
			$I_{OH} = -4\text{ mA}$	3.0	2.48	—	
			$I_{OH} = -8\text{ mA}$	4.5	3.80	—	
Low-level output voltage	$V_{OL}$	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OL} = 50\text{ }\mu\text{A}$	2.0	—	0.1	V
				3.0	—	0.1	
				4.5	—	0.1	
			$I_{OL} = 4\text{ mA}$	3.0	—	0.44	
			$I_{OL} = 8\text{ mA}$	4.5	—	0.44	
Input leakage current	$I_{IN}$	$V_{IN} = 5.5\text{ V or GND}$		0 to 5.5	—	$\pm 1.0$	$\mu\text{A}$
Quiescent supply current	$I_{CC}$	$V_{IN} = V_{CC} \text{ or GND}$		5.5	—	40.0	$\mu\text{A}$

13.3. DC Characteristics (Unless otherwise specified,  $T_a = -40$  to  $125\text{ }^\circ\text{C}$ )

Characteristics	Symbol	Test Condition		$V_{CC}$ (V)	Min	Max	Unit
High-level input voltage	$V_{IH}$	—		2.0	1.50	—	V
				3.0 to 5.5	$V_{CC} \times 0.7$	—	
Low-level input voltage	$V_{IL}$	—		2.0	—	0.50	V
				3.0 to 5.5	—	$V_{CC} \times 0.3$	
High-level output voltage	$V_{OH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -50\text{ }\mu\text{A}$	2.0	1.9	—	V
				3.0	2.9	—	
				4.5	4.4	—	
		$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -4\text{ mA}$	3.0	2.40	—	
			$I_{OH} = -8\text{ mA}$	4.5	3.70	—	
Low-level output voltage	$V_{OL}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OL} = 50\text{ }\mu\text{A}$	2.0	—	0.1	V
				3.0	—	0.1	
				4.5	—	0.1	
		$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OL} = 4\text{ mA}$	3.0	—	0.55	
			$I_{OL} = 8\text{ mA}$	4.5	—	0.55	
Input leakage current	$I_{IN}$	$V_{IN} = 5.5\text{ V}$ or GND		0 to 5.5	—	$\pm 2.0$	$\mu\text{A}$
Quiescent supply current	$I_{CC}$	$V_{IN} = V_{CC}$ or GND		5.5	—	80.0	$\mu\text{A}$

13.4. Timing Requirements (Unless otherwise specified,  $T_a = 25\text{ }^\circ\text{C}$ , Input:  $t_r = t_f = 3\text{ ns}$ )

Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	Limit	Unit
Minimum pulse width (CK)	$t_{w(L)}, t_{w(H)}$	—	$3.3 \pm 0.3$	5.0	ns
			$5.0 \pm 0.5$	5.0	
Minimum pulse width ( $\overline{\text{CLR}}$ )	$t_{w(L)}$	—	$3.3 \pm 0.3$	5.0	ns
			$5.0 \pm 0.5$	5.0	
Minimum setup time	$t_s$	—	$3.3 \pm 0.3$	5.0	ns
			$5.0 \pm 0.5$	4.5	
Minimum hold time	$t_h$	—	$3.3 \pm 0.3$	0.0	ns
			$5.0 \pm 0.5$	1.0	
Minimum removal time ( $\overline{\text{CLR}}$ )	$t_{rem}$	—	$3.3 \pm 0.3$	2.5	ns
			$5.0 \pm 0.5$	2.5	

## 13.5. Timing Requirements

(Unless otherwise specified,  $T_a = -40$  to  $85\text{ }^\circ\text{C}$ , Input:  $t_r = t_f = 3\text{ ns}$ )

Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	Limit	Unit
Minimum pulse width (CK)	$t_{w(L)}, t_{w(H)}$	—	$3.3 \pm 0.3$	5.0	ns
			$5.0 \pm 0.5$	5.0	
Minimum pulse width ( $\overline{\text{CLR}}$ )	$t_{w(L)}$	—	$3.3 \pm 0.3$	5.0	ns
			$5.0 \pm 0.5$	5.0	
Minimum setup time	$t_s$	—	$3.3 \pm 0.3$	6.0	ns
			$5.0 \pm 0.5$	4.5	
Minimum hold time	$t_h$	—	$3.3 \pm 0.3$	0.0	ns
			$5.0 \pm 0.5$	1.0	
Minimum removal time ( $\overline{\text{CLR}}$ )	$t_{rem}$	—	$3.3 \pm 0.3$	2.5	ns
			$5.0 \pm 0.5$	2.5	

## 13.6. Timing Requirements

(Unless otherwise specified,  $T_a = -40$  to  $125\text{ }^\circ\text{C}$ , Input:  $t_r = t_f = 3\text{ ns}$ )

Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	Limit	Unit
Minimum pulse width (CK)	$t_{w(L)}, t_{w(H)}$	—	$3.3 \pm 0.3$	5.0	ns
			$5.0 \pm 0.5$	5.0	
Minimum pulse width ( $\overline{\text{CLR}}$ )	$t_{w(L)}$	—	$3.3 \pm 0.3$	5.0	ns
			$5.0 \pm 0.5$	5.0	
Minimum setup time	$t_s$	—	$3.3 \pm 0.3$	6.0	ns
			$5.0 \pm 0.5$	4.5	
Minimum hold time	$t_h$	—	$3.3 \pm 0.3$	0.0	ns
			$5.0 \pm 0.5$	1.0	
Minimum removal time ( $\overline{\text{CLR}}$ )	$t_{\text{rem}}$	—	$3.3 \pm 0.3$	3.5	ns
			$5.0 \pm 0.5$	3.0	

13.7. AC Characteristics (Unless otherwise specified,  $T_a = 25\text{ }^\circ\text{C}$ , Input:  $t_r = t_f = 3\text{ ns}$ )

Characteristics	Symbol	Note	Test Condition	$V_{CC}$ (V)	$C_L$ (pF)	Min	Typ.	Max	Unit
Propagation delay time (CK-Q)	$t_{PLH}, t_{PHL}$		—	$3.3 \pm 0.3$	15	—	8.4	12.8	ns
					50	—	10.9	16.3	
				$5.0 \pm 0.5$	15	—	5.8	9.0	
					50	—	7.3	11.0	
Propagation delay time ( $\overline{\text{CLR}}$ -Q)	$t_{PHL}$		—	$3.3 \pm 0.3$	15	—	8.3	12.8	ns
					50	—	10.8	16.3	
				$5.0 \pm 0.5$	15	—	5.2	8.6	
					50	—	6.7	10.6	
Maximum clock frequency	$f_{\text{MAX}}$		—	$3.3 \pm 0.3$	15	80	125	—	MHz
					50	50	75	—	
				$5.0 \pm 0.5$	15	125	175	—	
					50	85	115	—	
Input capacitance	$C_{\text{IN}}$		—			—	4	10	pF
Power dissipation capacitance	$C_{\text{PD}}$	(Note 1)	—			—	76	—	pF

Note 1:  $C_{\text{PD}}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

$$I_{\text{CC(opr)}} = C_{\text{PD}} \times V_{\text{CC}} \times f_{\text{IN}} + I_{\text{CC}}$$

## 13.8. AC Characteristics

(Unless otherwise specified,  $T_a = -40$  to  $85\text{ }^\circ\text{C}$ , Input:  $t_r = t_f = 3\text{ ns}$ )

Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	$C_L$ (pF)	Min	Max	Unit
Propagation delay time (CK-Q)	$t_{PLH}, t_{PHL}$	—	$3.3 \pm 0.3$	15	1.0	15.0	ns
				50	1.0	18.5	
			$5.0 \pm 0.5$	15	1.0	10.5	
				50	1.0	12.5	
Propagation delay time ( $\overline{\text{CLR}}$ -Q)	$t_{PHL}$	—	$3.3 \pm 0.3$	15	1.0	15.0	ns
				50	1.0	18.5	
			$5.0 \pm 0.5$	15	1.0	10.0	
				50	1.0	12.0	
Maximum clock frequency	$f_{\text{MAX}}$	—	$3.3 \pm 0.3$	15	65	—	MHz
				50	45	—	
			$5.0 \pm 0.5$	15	105	—	
				50	75	—	
Input capacitance	$C_{\text{IN}}$	—			—	10	pF

## 13.9. AC Characteristics

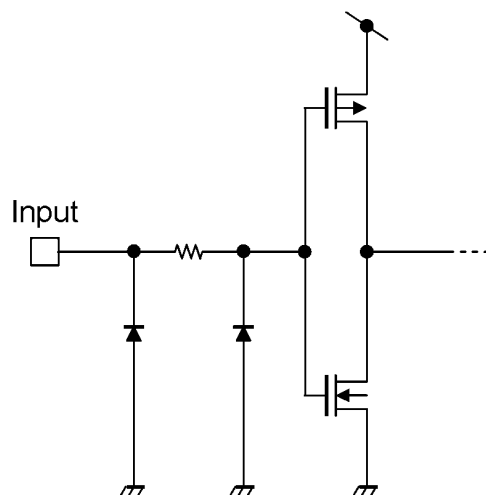
(Unless otherwise specified,  $T_a = -40$  to  $125\text{ }^{\circ}\text{C}$ , Input:  $t_r = t_f = 3\text{ ns}$ )

Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	$C_L$ (pF)	Min	Max	Unit
Propagation delay time (CK-Q)	$t_{PLH}, t_{PHL}$	—	$3.3 \pm 0.3$	15	1.0	17.0	ns
				50	1.0	20.5	
			$5.0 \pm 0.5$	15	1.0	12.0	
				50	1.0	14.0	
Propagation delay time ( $\overline{\text{CLR}}$ -Q)	$t_{PHL}$	—	$3.3 \pm 0.3$	15	1.0	17.0	ns
				50	1.0	20.5	
			$5.0 \pm 0.5$	15	1.0	11.5	
				50	1.0	13.5	
Maximum clock frequency	$f_{MAX}$	—	$3.3 \pm 0.3$	15	60	—	MHz
				50	40	—	
			$5.0 \pm 0.5$	15	100	—	
				50	65	—	
Input capacitance	$C_{IN}$	—	—	—	—	10	pF

13.10. Noise Characteristics (Unless otherwise specified,  $T_a = 25\text{ }^{\circ}\text{C}$ , Input:  $t_r = t_f = 3\text{ ns}$ )

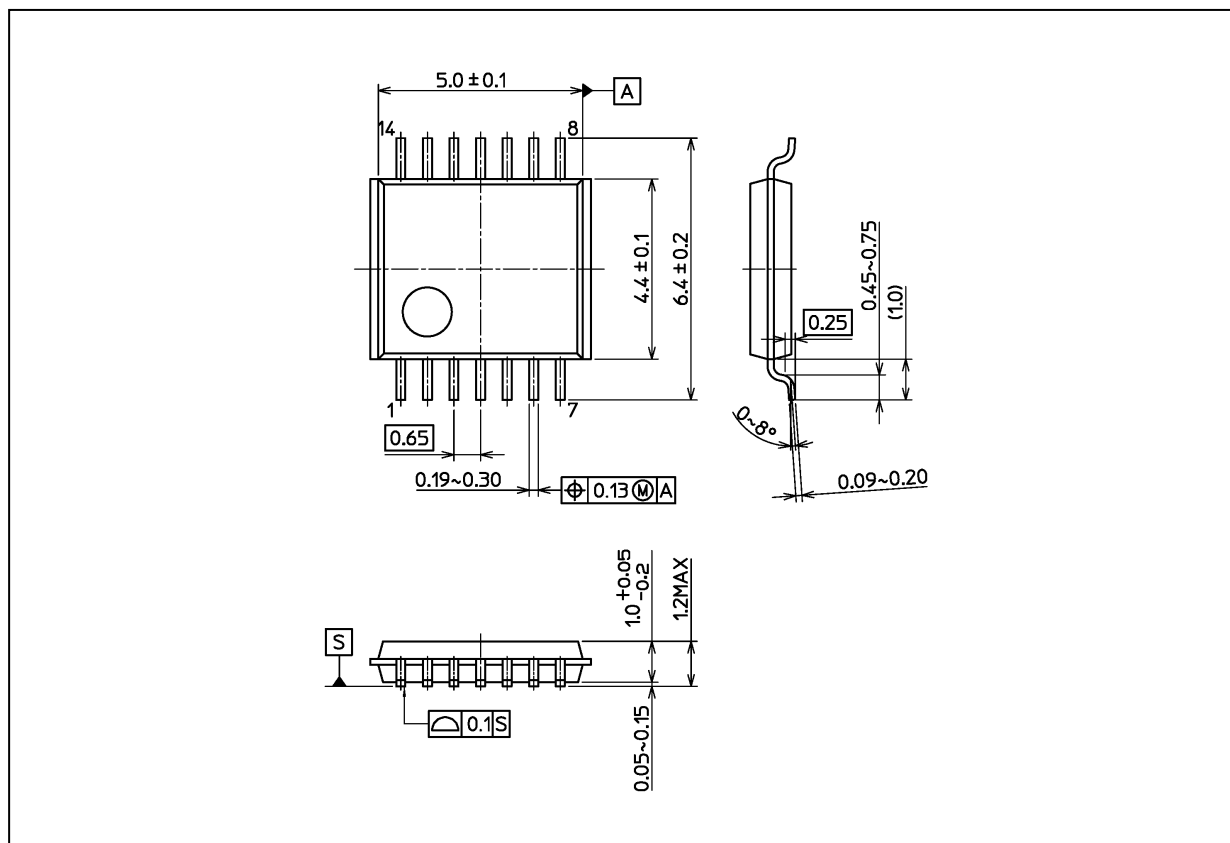
Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	Typ.	Limit	Unit
Quiet output maximum dynamic $V_{OL}$	$V_{OLP}$	$C_L = 50\text{ pF}$	5.0	0.5	0.8	V
Quiet output minimum dynamic $V_{OL}$	$V_{OLV}$	$C_L = 50\text{ pF}$	5.0	-0.5	-0.8	V
Minimum high-level dynamic input voltage	$V_{IHD}$	$C_L = 50\text{ pF}$	5.0	—	3.5	V
Maximum low-level dynamic input voltage	$V_{ILD}$	$C_L = 50\text{ pF}$	5.0	—	1.5	V

## 14. Internal Equivalent Circuit



## Package Dimensions

Unit: mm



Weight: 0.054 g (typ.)

Package Name(s)
Nickname: TSSOP14B



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